

Fast Thyristor

AT600F

Key Parameters

$I_{TAV(M)}$	=	600	A
V_{DRM}/V_{RRM}	=	600 - 1300	V
I_{TSM}	=	10 000	A
V_{TO}	=	1.15	V
r_T	=	0.42	mΩ

Properties

- International standard package
- Metal case with ceramic insulator
- Low on-state and switching losses
- High operation reliability
- Optimum power handling capability

MAXIMUM ALLOWABLE RATINGS

Symbols and parameters			Maximum Limits	Unit
V_{DRM}	Repetitive peak forward voltage		600	V
V_{RRM}	Repetitive peak reverse voltage		1000	V
			1200	V
I_{TAVM}	Average on-state current	$t_C = 85\text{ °C}$	600	A
		$t_C = 47\text{ °C}$	960	A
I_{TRMSM}	RMS on-state current		1500	A
I_{TSM}	Surge current	$t_{vj} = 45\text{ °C}, t_p = 10\text{ ms}$	11 300	A
		$t_{vj} = t_{vj\text{ max}}, t_p = 10\text{ ms}$	10 000	A
I^2t	I^2t -value	$t_{vj} = 45\text{ °C}, t_p = 10\text{ ms}$	638	kA ² s
		$t_{vj} = t_{vj\text{ max}}, t_p = 10\text{ ms}$	500	kA ² s
$(dv/dt)_{cr}$	Critical rate of rise of off-state voltage	$t_{vj} = t_{vj\text{ max}}$ $V_D = 0.67 V_{DRM}$		
			1)	2)
		B:	50	50
		C*:	400	400
		L:	400	50
		M*:	1000	400
$(di/dt)_{cr}$	Critical rate of rise of on-state current	non rep. rep., $di_G/dt = 1\text{ A}/\mu\text{s}$ $I_{TM} = 2.5\text{ kA}, I_G = 1\text{ A}$	900	A/ μs
			200	A/ μs

CHARACTERISTICS

Symbols and parameters			Value			Unit
			min	typ	max	
v_T	On-state voltage	$t_{vj} = t_{vj \max}, I_T = 2.5 \text{ kA}$			2.35	V
$V_{(TO)}$	Threshold voltage	$t_{vj} = t_{vj \max}$	1.15			V
r_T	Slope resistance	$t_{vj} = t_{vj \max}$	0.42			mΩ
I_{GT}	Gate trigger current	$t_{vj} = 25^\circ\text{C}, v_D = 6 \text{ V}, R_A = 5 \Omega$			250	mA
		$t_{vj} = t_{vj \max}, v_D = 6 \text{ V}, R_A = 5 \Omega$			10	mA
V_{GT}	Gate trigger voltage	$t_{vj} = 25^\circ\text{C}, v_D = 6 \text{ V}, R_A = 5 \Omega$			2.2	V
I_H	Holding current	$t_{vj} = 25^\circ\text{C}, v_D = 6 \text{ V}, R_A = 5 \Omega$			250	mA
I_L	Latching current	$t_{vj} = 25^\circ\text{C}, v_D = 6 \text{ V}$ $R_{GK} \geq 10 \Omega, I_G = 1 \text{ A}$ $di_G/dt = 1 \text{ A}/\mu\text{s}$ $t_g = 20 \mu\text{s}$			1	A
i_D, i_R	Forward off-state and reverse current	$t_{vj} = t_{vj \max}$ $v_D = V_{DRM}, v_R = V_{RRM}$			100	mA
t_{gd}	Gate controlled delay time	$I_G = 1 \text{ A}, di_G/dt = 1 \text{ A}/\mu\text{s}$			1.5	μs
t_q	Turn-off time	See Techn. Inf.			E: 20 F: 25 G: 30	μs μs μs
Q_s	Stored charge	$t_{vj} = t_{vj \max}, I_{TM} = 800 \text{ A}$ $-di_T/dt = 20 \text{ A}/\mu\text{s}$			130	μAs
C_{null}	Null capacitance	$t_{vj} = 25^\circ\text{C}, f = 10 \text{ kHz}$			8	nF

THERMAL PARAMETERS

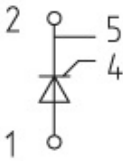
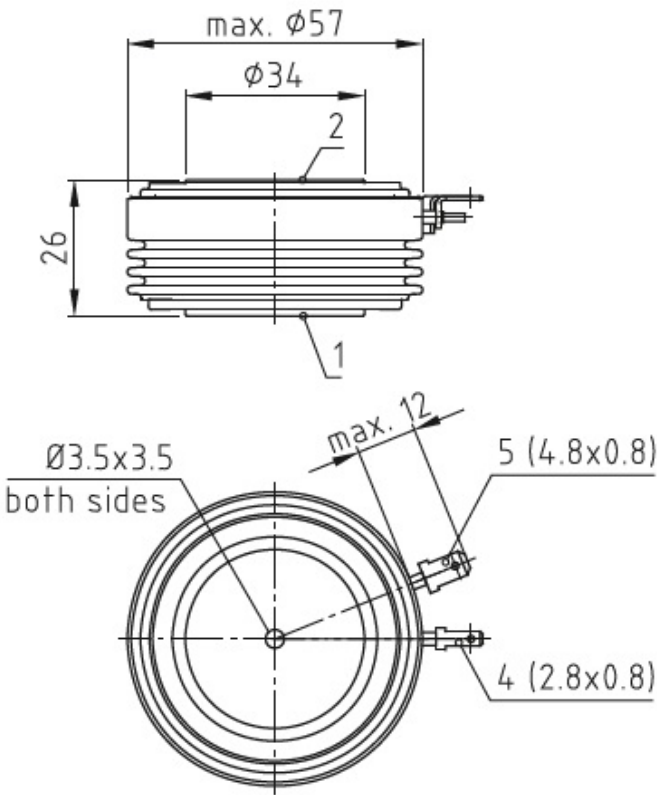
Symbols and parameters			Value	Unit
$R_{th(j-c)}$	Thermal resistance, junction to case	Two-sided cooling, $\theta = 180^\circ \text{ el, sin}$	0.038	$^\circ\text{C}/\text{W}$
		Two-sided cooling, DC	0.036	
		Anode-sided cooling, $\theta = 180^\circ \text{ el, sin}$	0.0675	
		Anode-sided cooling, DC	0.065	
		Cathode-sided cooling, $\theta = 180^\circ \text{ el, sin}$	0.82	
		Cathode-sided cooling, DC	0.08	
$R_{th(c-h)}$	Thermal resistance, case to heatsink		0.02	$^\circ\text{C}/\text{W}$
$t_{vj \max}$	Maximum junction temperature		+125	$^\circ\text{C}$
$t_{vj \text{ op}}$	Operating temperature range		-40 ... +125	$^\circ\text{C}$
t_{stg}	Storage temperature range		-40 ... +150	$^\circ\text{C}$

MECHANICAL PARAMETERS

Symbols and parameters			Value	Unit
F	Clamping force		12 – 15	kN
W	Weight		300	g
D	Creepage distance		25	mm

* - Delivery for larger quantities on request
1) - Values to DIN 41787 (without prior commutation)
2) - Immediately after circuit commutated turn-off time

DIMENSIONS



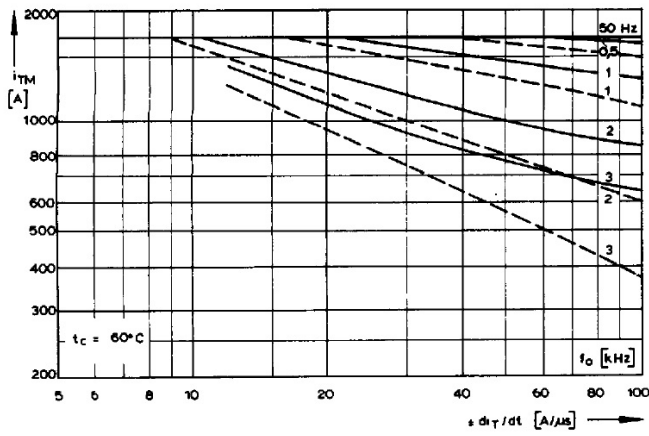


Fig. 1

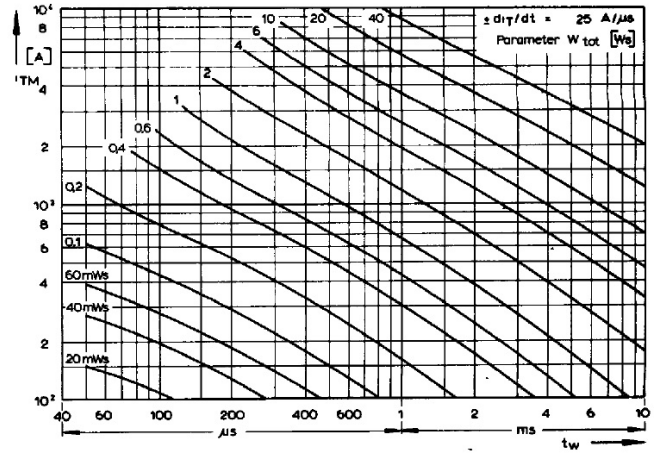


Fig. 4

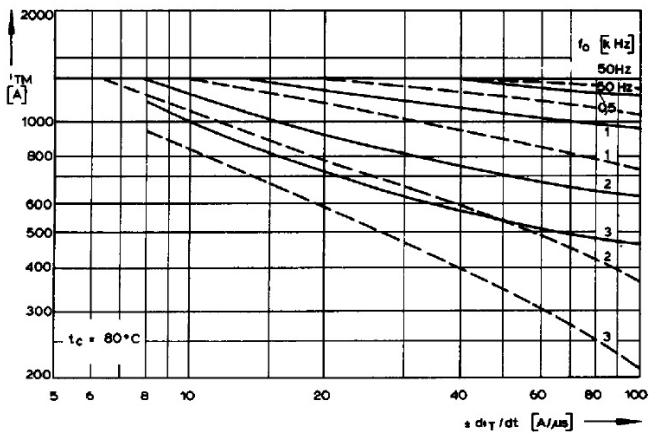


Fig. 2

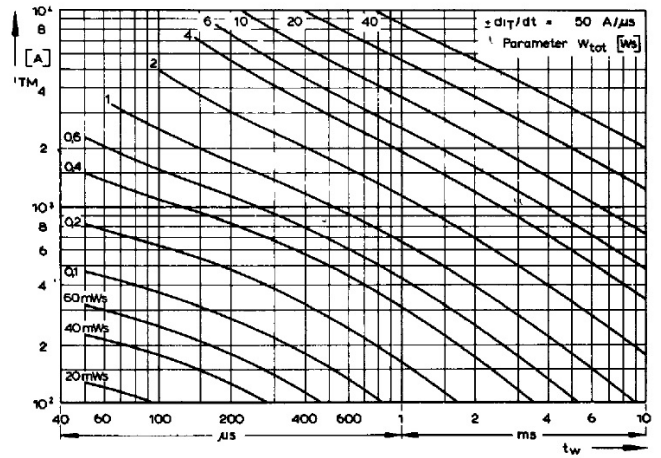


Fig. 5

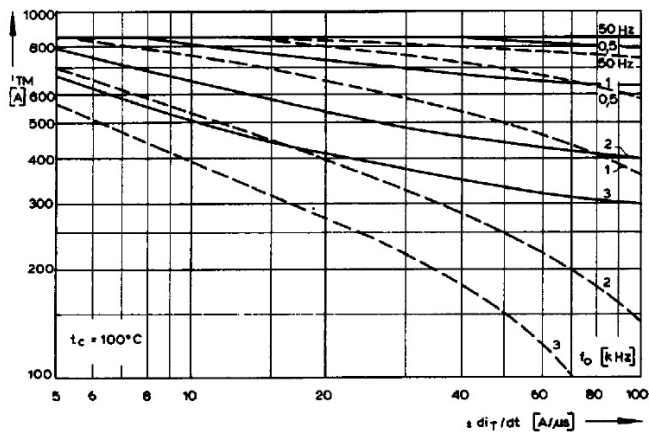


Fig. 3

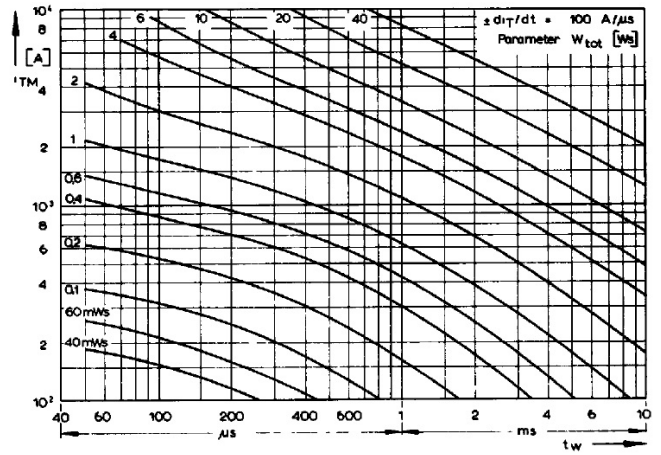


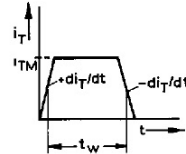
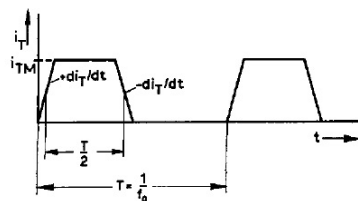
Fig. 6

Pulse generator:
 $i_G = 1 \text{ A}$, $t_a = 1 \mu\text{s}$

RC-network:
 $R [\Omega] \geq 0.02 v_{DM} [\text{V}]$
 $C \leq 0.33 \mu\text{F}$
 $dv_R/dt \leq 600 \text{ V}/\mu\text{s}$

Pulse generator:
 $i_G = 1 \text{ A}$, $t_a = 1 \mu\text{s}$

RC-network:
 $R [\Omega] \geq 0.02 v_{DM} [\text{V}]$
 $C \leq 0.33 \mu\text{F}$



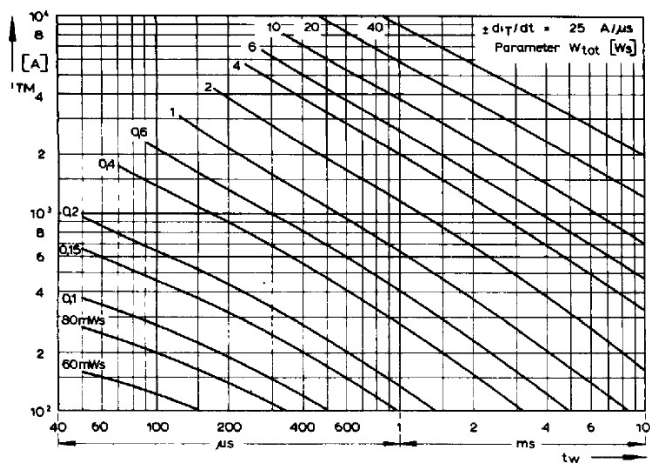


Fig. 7

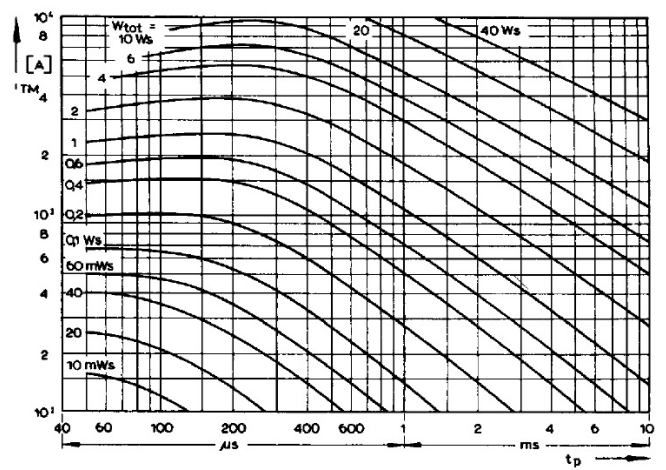


Fig. 10

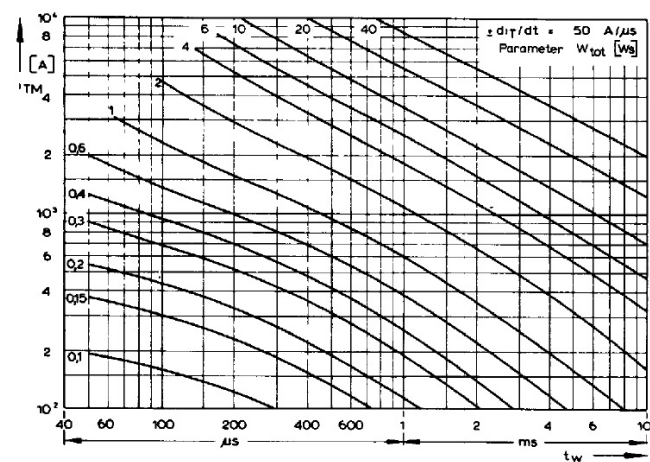


Fig. 8

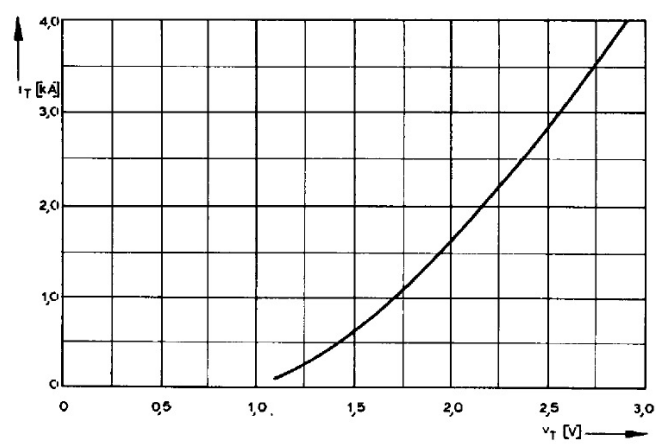


Fig. 11

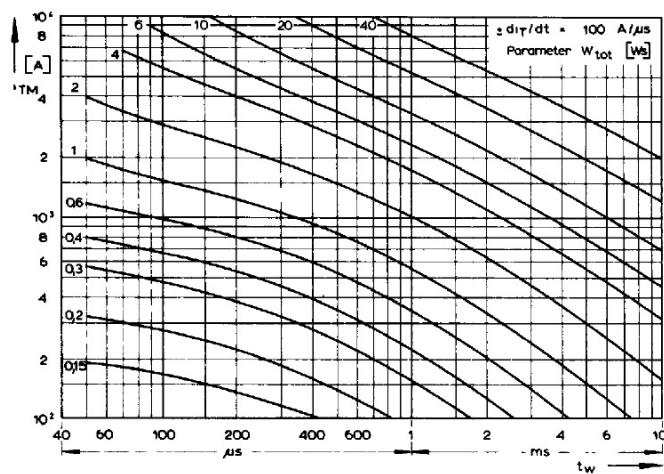


Fig. 9

Pulse generator:
 $i_G = 1 \text{ A}$, $t_a = 1 \mu\text{s}$

RC-network:
 $R [\Omega] \geq 0.02 v_{DM} [V]$
 $C \leq 0.33 \mu\text{F}$
 $dv_R/dt \leq 600 \text{ V}/\mu\text{s}$

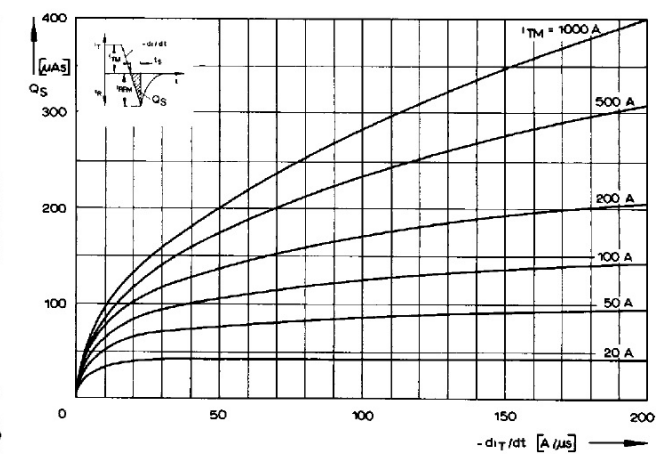
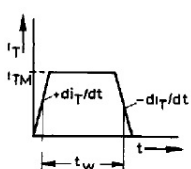
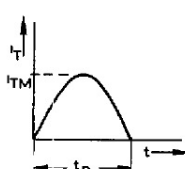


Fig. 12

Pulse generator:
 $i_G = 1 \text{ A}$, $t_a = 1 \mu\text{s}$

RC-network:
 $R [\Omega] \geq 0.02 v_{DM} [V]$
 $C \leq 0.22 \mu\text{F}$



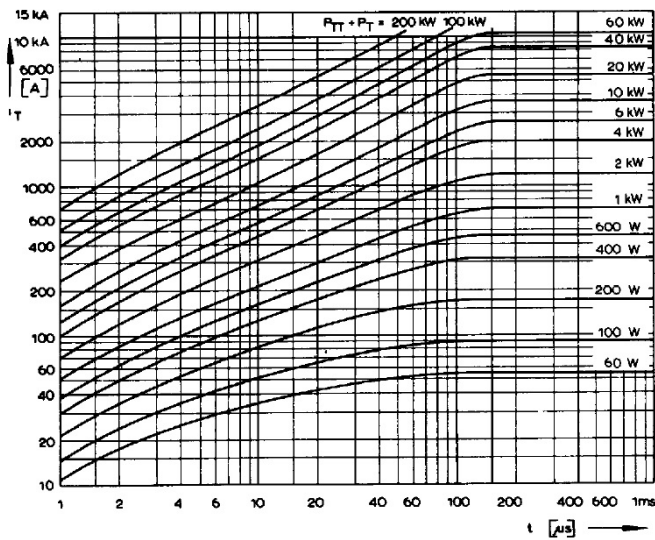


Fig. 13
Diagram for the determination of the sum of the turn-on and forward on-state power loss ($P_{TT} + P_T$)

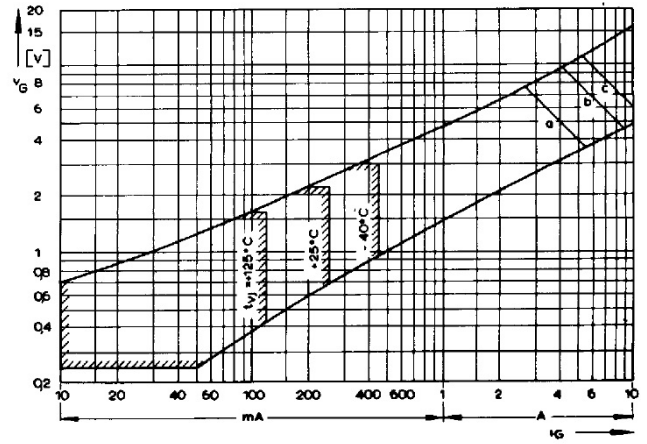


Fig. 16
Gate characteristic and peak gate power dissipation at $v_D \geq 6$ V
Parameter: Pulse duration t_g [ms]: a - 10; b - 1; c - 0.5
Maximum allowable peak gate power [W]: a - 20; b - 40; c - 60

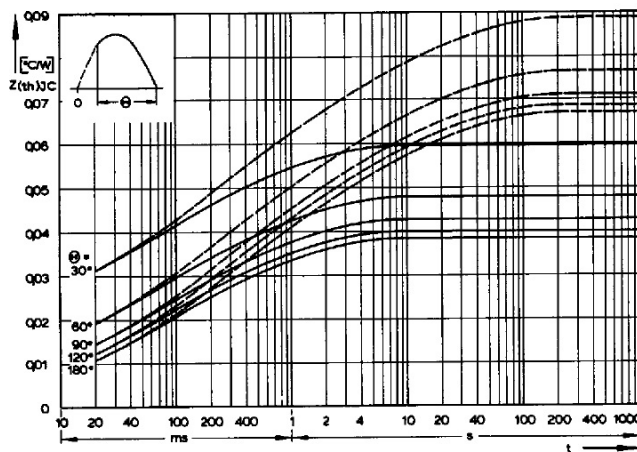


Fig. 14
Transient thermal impedance, junction to case $Z_{(th)JC}$
-- Anode sided cooling
— Two-sided cooling

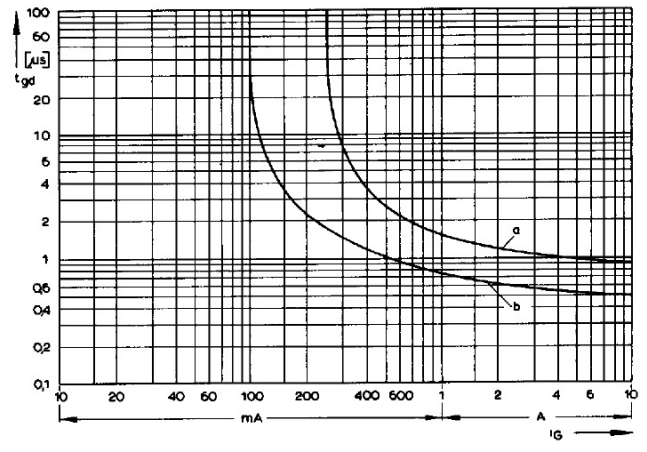


Fig. 17
Gate controlled delay time t_{gd} to DIN 41787 at $t_{vj} = 25$ °C, $t_a = 1$ μs
a — Limiting characteristic
b — Typical characteristic

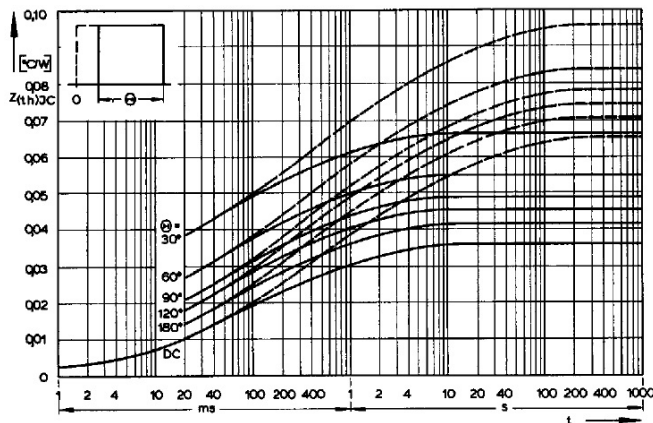


Fig. 15
Transient thermal impedance, junction to case $Z_{(th)JC}$
-- Anode sided cooling
— Two-sided cooling

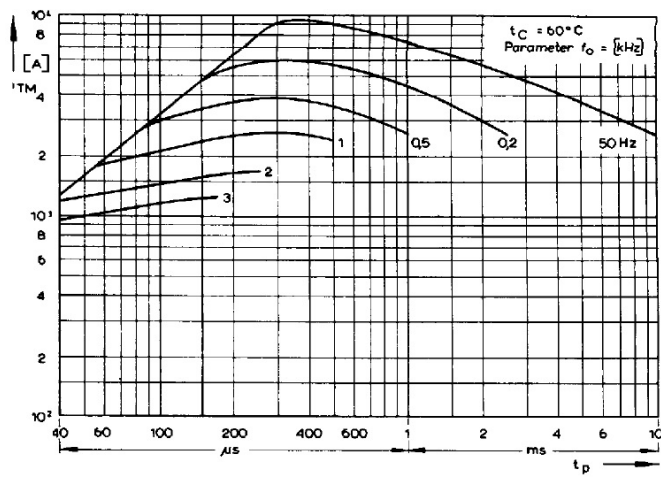


Fig. 18

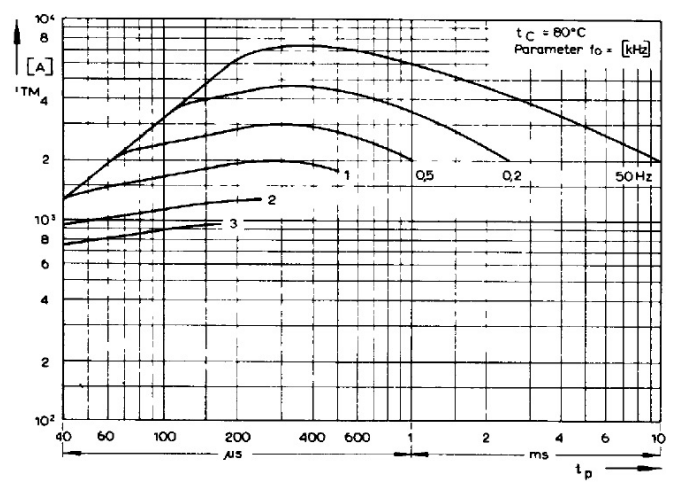


Fig. 20

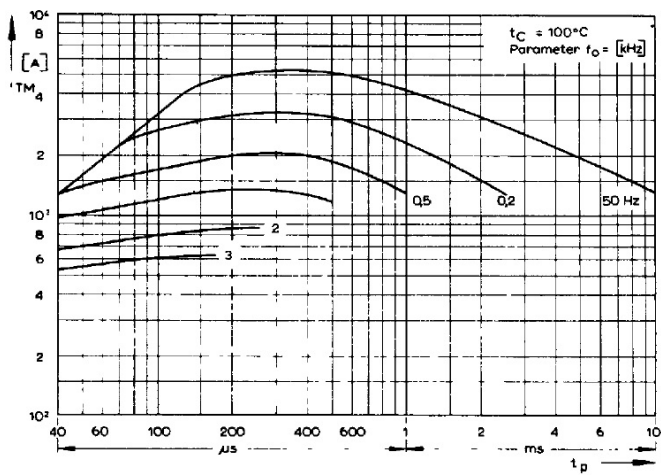


Fig. 19

Pulse generator:
 $i_G = 1 \text{ A}$, $t_a = 1 \mu\text{s}$

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